

N-Channel Switch

This device is designed for analog or digital switching applications where very low On Resistance is mandatory. Sourced from Process 58. See J108 for characteristics.

Absolute Maximum Ratings*

TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units	
V_{DG}	Drain-Gate Voltage	25	V	
V _{GS}	Gate-Source Voltage	-25	V	
I _{GF}	Forward Gate Current	10	mA	
T _J , T _{stg}	Operating and Storage Junction Temperature Range -5		°C	

*These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

NOTES:

1) These ratings are based on a maximum junction temperature of 150 degrees C.2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Thermal Characteristics

Symbol	Characteristic	Мах	Units
		PN5432 / 5433 / 5434	-
P _D	Total Device Dissipation	350	mW
	Derate above 25°C	2.8	mW/°C
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case	125	°C/W
R _{0JA}	Thermal Resistance, Junction to Ambient	357	°C/W

TA = 25°C unless otherwise noted

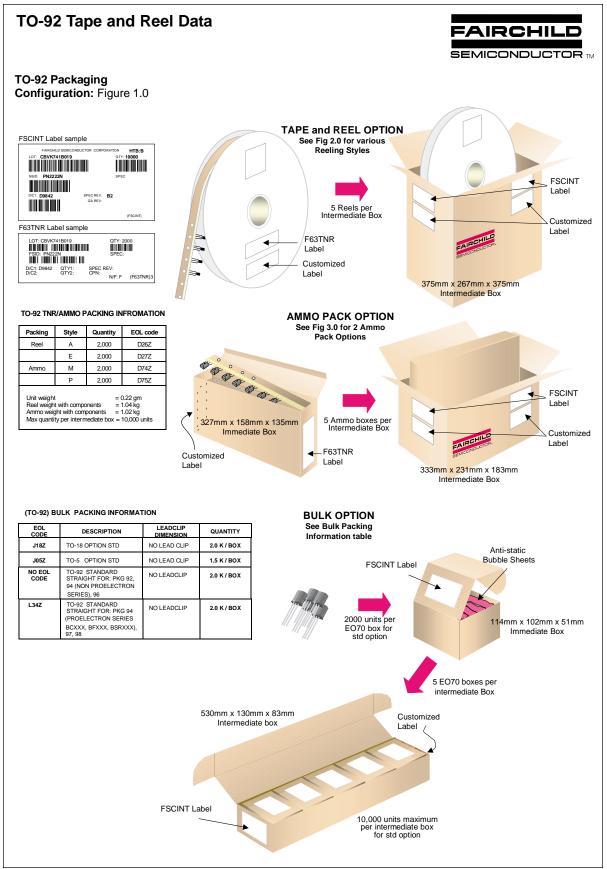
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N-Channel Switch (continued)

Symbol	Parameter	Test Conditions	Min	Max	Units
				-	• •
OFF CHA	RACTERISTICS				
V _{(BR)GSS}	Gate-Source Breakdown Voltage	$I_{G} = 1.0 \ \mu A, \ V_{DS} = 0$	-25		V
GSS	Gate Reverse Current	$V_{GS} = 15 \text{ V}, \text{ V}_{DS} = 0$		-200	pА
		$V_{GS} = 15 \text{ V}, V_{DS} = 0, T_A = 150 \text{ °C}$		-200	nA
D(off)	Drain Cutoff Leakage Voltage	$V_{GS} = 10 \text{ V}, V_{DS} = 5.0 \text{ V}$ $V_{GS} = 10 \text{ V}, V_{DS} = 5.0 \text{ V},$		-200	pА
		$V_{GS} = 10$ V, $V_{DS} = 3.0$ V, $T_A = 150$ °C		-200	nA
/ _{GS(off)}	Gate-Source Cutoff Voltage		32 -4.0	-10	V
	_	54	-3.0	-9.0	V
		54	34 -1.0	-4.0	V
ON CHAF	RACTERISTICS				
DSS	Zero-Gate Voltage Drain Current*	50 , 60	132 150		mA
		_	133 100		mA
V _{DS(on)}	Drain-Source On Voltage		134 30 132	50	mA mV
V DS(on)	Drain-Source On Voltage		133	70	mV
		54	134	100	mV
DS(on)	Drain-Source On Resistance	10 10 10 10 10	132 2.0	5.0	Ω
		_	133	7.0	Ω
		$I_{\rm D} = 0, V_{\rm GS} = 0, f = 1.0 \text{ kHz}$	134	10	Ω
			432 2.0	5.0	Ω
		54	133	7.0	Ω
		54	134	10	Ω
SMALL S	IGNAL CHARACTERISTICS				
C _{iss}	Input Capacitance	V_{DS} = 0 , V_{GS} = 10 V, f = 1.0 MH		30	pF
C _{rss}	Reverse Transfer Capacitance	V_{DS} = 0 , V_{GS} = 10 V, f = 1.0 MH	z	15	pF
SWITCHI	NG CHARACTERISTICS				
d	Delay Time	$V_{DD} = 1.5 V, V_{GS(on)} = 0,$		4.0	ns
r	Rise Time	$I_{D(on)} = 10 \text{ mA}$		1.0	ns
ls.	Storage Time	$V_{GS(off)} = 12 V,$			
			432	6.0	ns
			433	6.0	ns
			434	6.0	ns
	Fall Time	DO(01)			

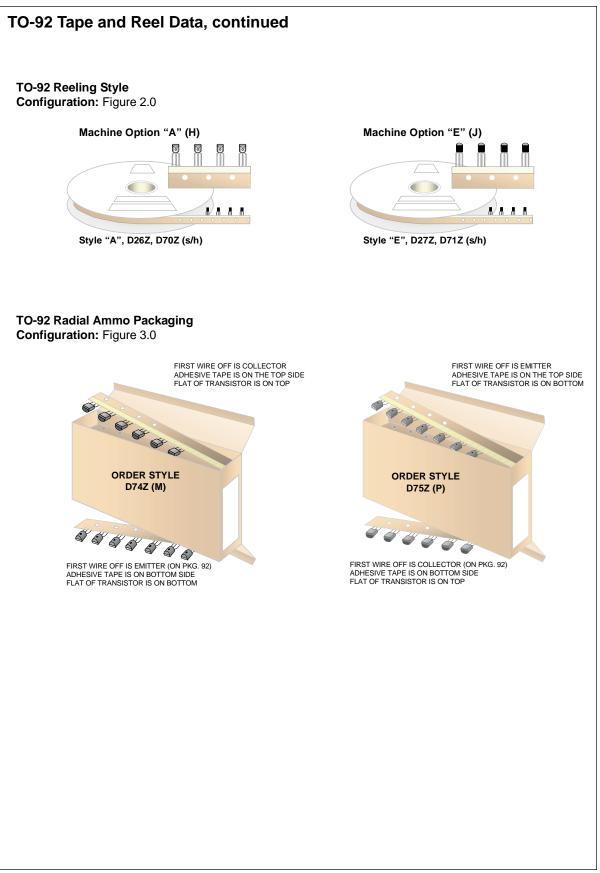
*Pulse Test: Pulse Width \leq 300 $\mu s,$ Duty Cycle \leq 2.0%

PN5432 / PN5433 / PN5434



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